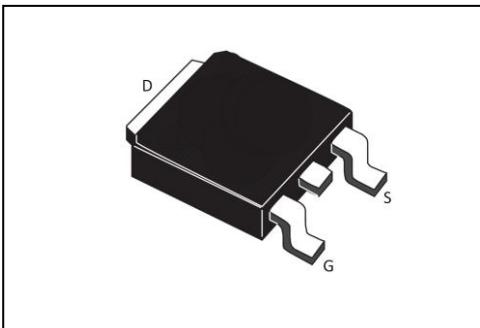


Silicon N-Channel Power MOSFET

General Description :

XCH4N65M the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-252, which accords with the RoHS standard.

V _{DSS}	650	V
I _D	4	A
P _D (T _C =25°C)	75	W
R _{DS(ON)typ}	2.5	Ω



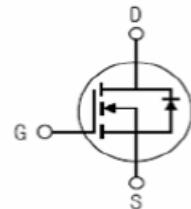
Features :

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

Applications :

- LED Lighting
- Charger
- Standby Power

Inner Equivalent Principium Chart



Absolute (T_C=25°C unless otherwise specified) :

Symbol	Parameter	Rating	Units
V _{DSS}	Drain-to-Source Voltage	650	V
I _D	Continuous Drain Current	4	A
	Continuous Drain Current T _C = 100 °C	2.5	A
I _{DM} ^{a1}	Pulsed Drain Current	16	A
V _{GS}	Gate-to-Source Voltage	±30	V
E _{AS} ^{a2}	Single Pulse Avalanche Energy	200	mJ
dv/dt ^{a3}	Peak Diode Recovery dv/dt	5.0	V/ns
P _D	Power Dissipation	75	W
	Derating Factor above 25°C	0.6	W/°C
T _J , T _{stg}	Operating Junction and Storage Temperature Range	150 , -55 to 150	°C
T _L	Maximum Temperature for Soldering	300	°C

Silicon N-Channel Power MOSFET
Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	650	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu\text{A}$, Reference 25°C	--	0.67	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_a=25^\circ\text{C}$	--	--	1	μA
		$V_{DS}=520\text{V}, V_{GS}=0\text{V}, T_a=125^\circ\text{C}$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30\text{V}$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30\text{V}$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(\text{ON})}$	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=2\text{A}$	--	2.50	2.80	Ω
$V_{GS(\text{TH})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.0	3.0	4.0	V
Pulse width $t_p \leq 300\mu\text{s}, \delta \leq 2\%$						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g_{fs}	Forward Transconductance	$V_{DS}=15\text{V}, I_D=2\text{A}$	--	3.5	--	S
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$	--	610	--	pF
C_{oss}	Output Capacitance	$f=1.0\text{MHz}$	--	53	--	
C_{rss}	Reverse Transfer Capacitance		--	3.5	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(\text{ON})}$	Turn-on Delay Time		--	15	--	ns
t_r	Rise Time	$I_D=4\text{A}, V_{DD}=325\text{V}$	--	30	--	
$t_{d(\text{OFF})}$	Turn-Off Delay Time	$R_G=10\Omega$	--	50	--	
t_f	Fall Time		--	40	--	
Q_g	Total Gate Charge	$I_D=4\text{A}, V_{DD}=325\text{V}$	--	10	--	nC
Q_{gs}	Gate to Source Charge	$V_{GS}=10\text{V}$	--	3.4	--	
Q_{gd}	Gate to Drain ("Miller")Charge		--	2.7	--	

Silicon N-Channel Power MOSFET
Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current (Body Diode)		--	--	4	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	16	A
V _{SD}	Diode Forward Voltage	I _S =4.0A, V _{GS} =0V	--	--	1.5	V
t _{rr}	Reverse Recovery Time	I _S =4.0A, T _j =25°C	--	256	--	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt=100A/us,	--	1200	--	uC
I _{RRM}	Reverse Recovery Current	V _{GS} =0V	--	9.4	--	A

Pulse width tp≤300μs, δ≤2%

Symbol	Parameter	Typ.	Units
R _{θJC}	Junction-to-Case	1.67	°C/W
R _{θJA}	Junction-to-Ambient	100	°C/W

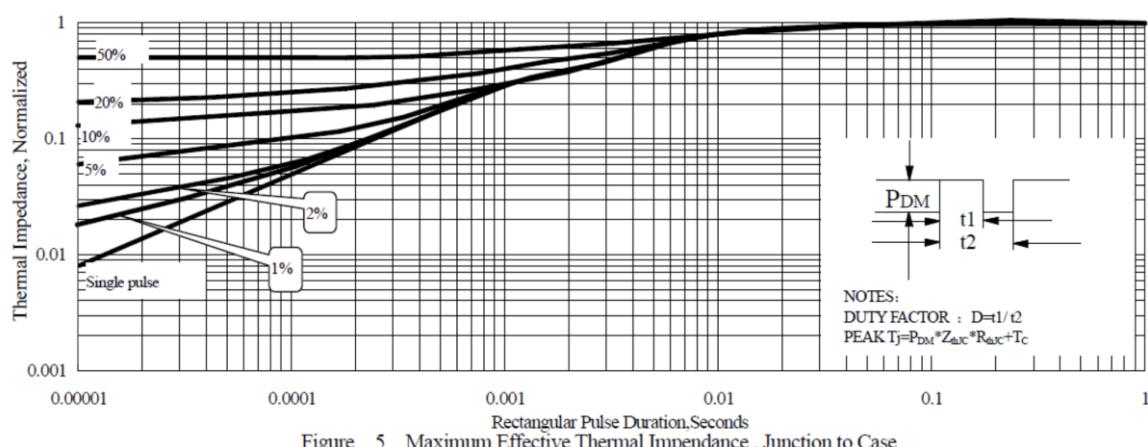
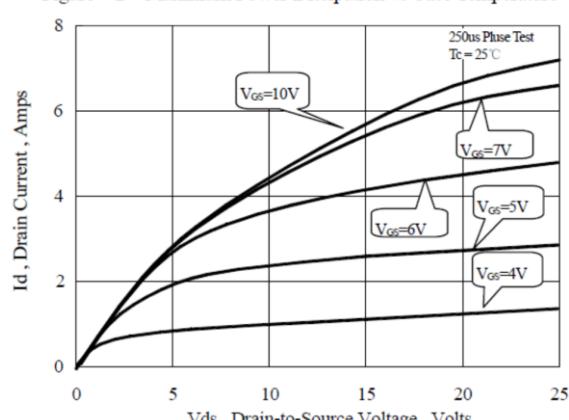
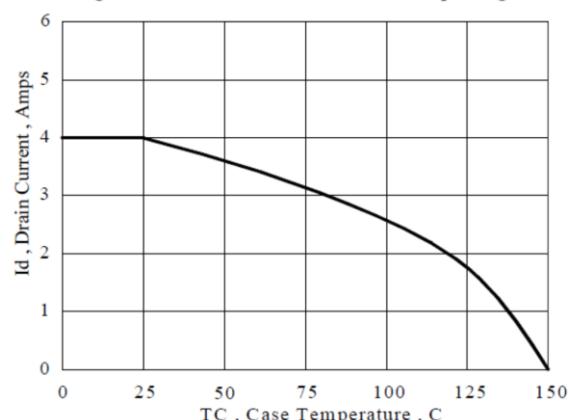
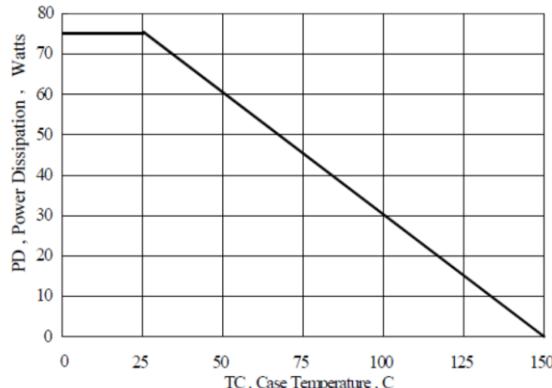
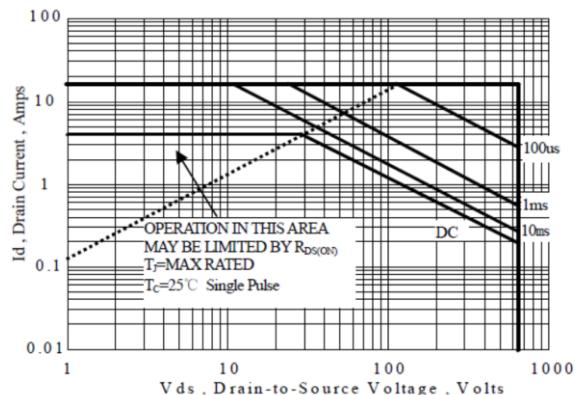
^{a1} : Repetitive rating; pulse width limited by maximum junction temperature

^{a2} : L=10.0mH, I_D=6.3A, Start T_j=25°C

^{a3} : I_{SD} =4A, di/dt ≤100A/us, V_{DD}≤BV_{DS}, Start T_j=25°C

Silicon N-Channel Power MOSFET

Characteristics Curve :



Silicon N-Channel Power MOSFET

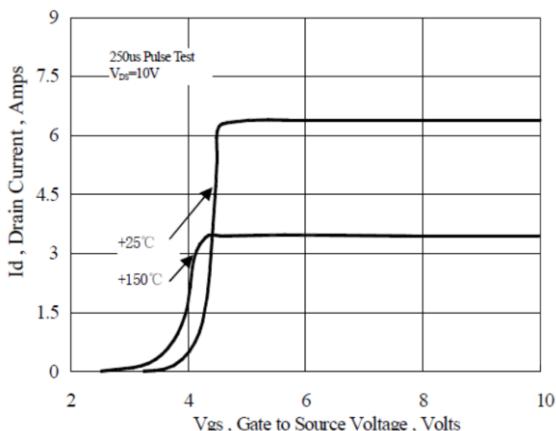


Figure 6 Typical Transfer Characteristics

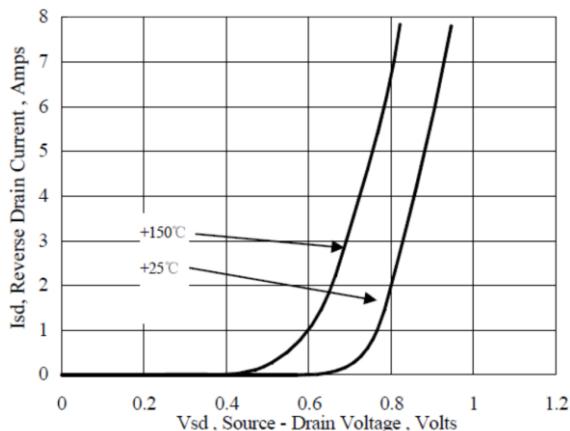


Figure 7 Typical Body Diode Transfer Characteristics

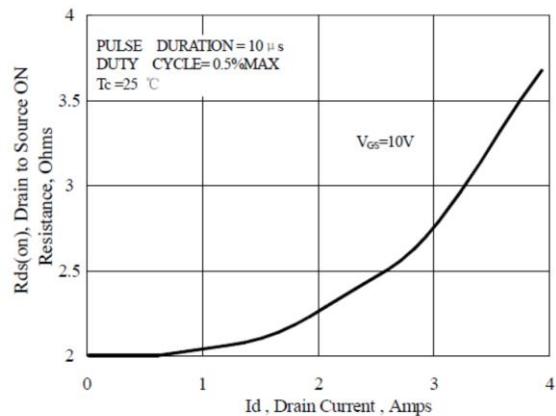


Figure 8 Typical Drain to Source ON Resistance vs Drain Current

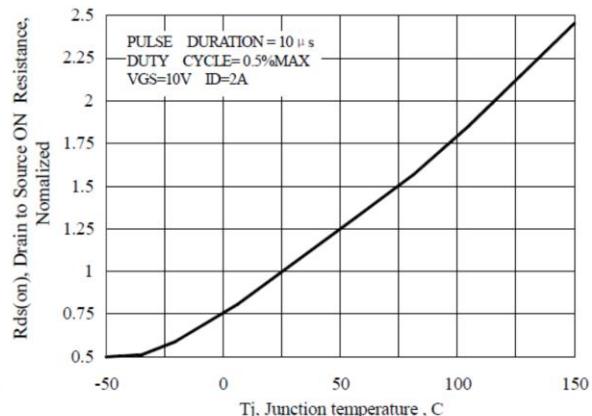


Figure 9 Typical Drian to Source on Resistance vs Junction Temperature

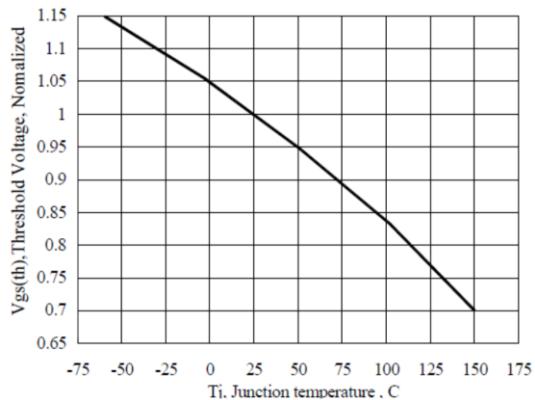


Figure 10 Typical Threshold Voltage vs Junction Temperature

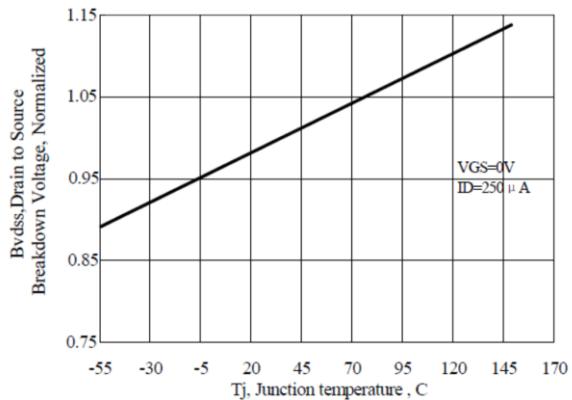


Figure 11 Typical Breakdown Voltage vs Junction Temperature